

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination LAPUH ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0185181 A1	10-2003	Balachandran et al.	370/337
*	B	US-2007/0198670 A1	08-2007	Andreev et al.	709/220
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